## DISCRETE SEMICONDUCTORS

## DATA SHEET

# **BLT50**UHF power transistor

Product specification
File under Discrete Semiconductors, SC08b

**April 1991** 





## **UHF** power transistor

**BLT50** 

#### **FEATURES**

- SMD encapsulation
- Gold metallization ensures excellent reliability.

#### **DESCRIPTION**

NPN silicon planar epitaxial transistor encapsulated in a SOT223 surface mounted envelope and designed primarily for use in hand-held radio equipment in the 470 MHz communications band.

#### **PINNING - SOT223**

PIN	DESCRIPTION
1	emitter
2	base
3	emitter
4	collector

#### **QUICK REFERENCE DATA**

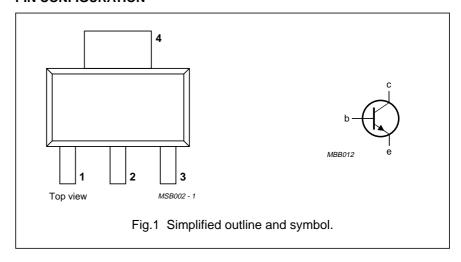
RF performance at  $T_s \leq$  60  $^{\circ}C$  in a common emitter class-B test circuit (note 1).

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>c</sub> (%)
c.w. narrow band	470	7.5	1.2	> 10	> 55

#### Note

1.  $T_s$  = temperature at soldering point of collector tab.

#### **PIN CONFIGURATION**



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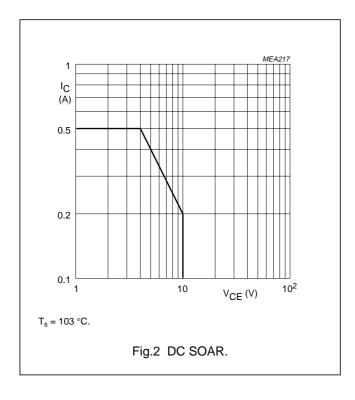
#### **LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	_	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	10	V
$V_{EBO}$	emitter-base voltage	open collector	_	3	V
I <sub>C</sub> , I <sub>C(AV)</sub>	collector current	DC or average value	_	500	mA
Ісм	collector current	peak value f > 1 MHz	_	1.5	А
P <sub>tot</sub>	total power dissipation	f > 1 MHz; T <sub>s</sub> = 103 °C (note 1)	_	2	W
T <sub>stg</sub>	storage temperature range		-65	150	°C
T <sub>j</sub>	operating junction temperature		_	175	°C

#### Note

1.  $T_s$  = temperature at soldering point of collector tab.



#### THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
R <sub>th j-s(DC)</sub>	from junction to soldering point	$P_{tot} = 2 \text{ W}; T_s = 103 ^{\circ}\text{C}$	36	K/W

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#### **CHARACTERISTICS**

 $T_j = 25 \, ^{\circ}C$ .

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter; I <sub>C</sub> = 5 mA	20	_	_	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base; I <sub>C</sub> = 10 mA	10	_	_	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	open collector; I <sub>E</sub> = 1 mA	3	_	_	V
I <sub>CES</sub>	collector-emitter leakage current	V <sub>BE</sub> = 0; V <sub>CE</sub> = 10 V	_	_	250	μА
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 5 V; I <sub>C</sub> = 300 mA	25	_	_	
E <sub>SBR</sub>	second breakdown energy	$L = 25 \text{ mH};$ $R_{BE} = 10 \Omega;$ $f = 50 \text{ Hz}$	0.55	_	_	mJ
C <sub>c</sub>	collector capacitance	$V_{CB} = 7.5 \text{ V};$ $I_{E} = I_{e} = 0;$ $f = 1 \text{ MHz}$	_	4.7	6	pF
C <sub>re</sub>	feedback capacitance	$V_{CE} = 7.5 \text{ V};$ $I_{C} = 0;$ $f = 1 \text{ MHz}$	_	2.9	4.5	pF

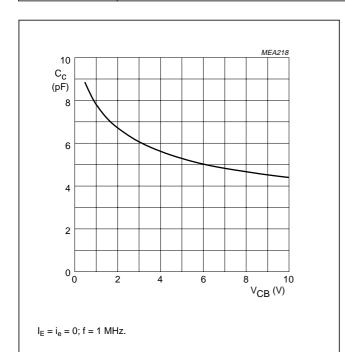


Fig.3 Collector capacitance as a function of collector-base voltage, typical values.

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#### **APPLICATION INFORMATION**

RF performance at  $T_s \leq 60~^{\circ}C$  in a common emitter class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>CE</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>c</sub> (%)
c.w. narrow band	470	7.5	1.2	> 10 typ. 11.2	> 55 typ. 65

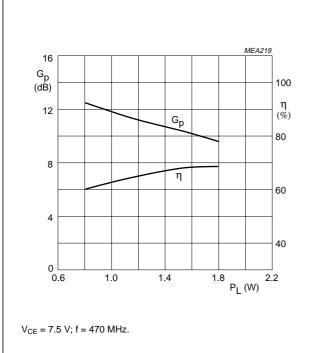


Fig.4 Gain and efficiency as functions of load power, typical values.

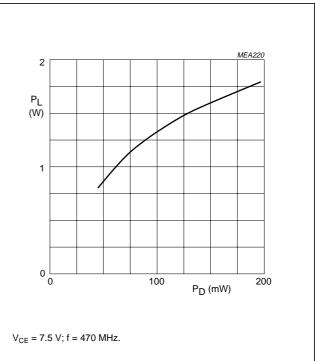


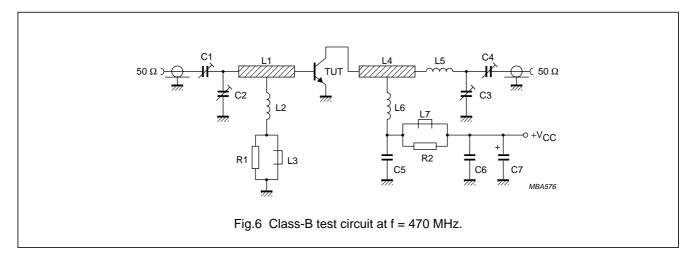
Fig.5 Load power as a function of drive power, typical values.

#### Ruggedness in class-B operation

The BLT50 is capable of withstanding a load mismatch corresponding to VSWR = 50:1 through all phases at rated output power, up to a supply voltage of 9 V, f = 470 MHz and  $T_s \leq 60~^{\circ}\text{C}$ , where  $T_s$  is the temperature at the soldering point of the collector tab.

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#### List of components (see test circuit)

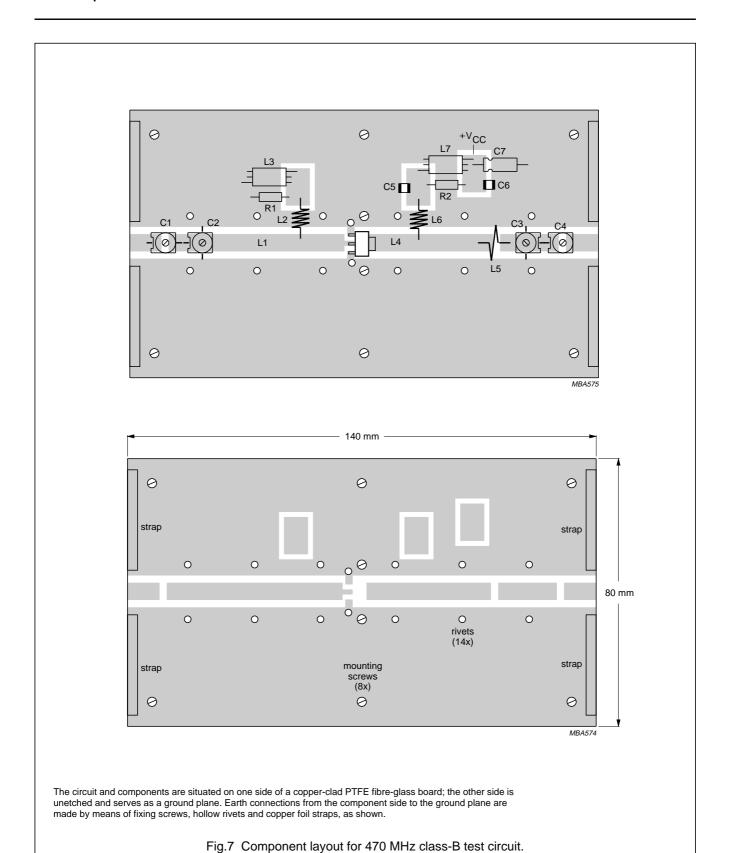
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09004
C2	film dielectric trimmer	1.4 to 5.5 pF		2222 809 09001
C3	film dielectric trimmer	2 to 9 pF		2222 809 09002
C4	film dielectric trimmer	2 to 9 pF		2222 809 09005
C5	multilayer ceramic chip capacitor (note 1)	100 pF		
C6	multilayer ceramic chip capacitor (note 1)	1 nF		
C7	63 V electrolytic capacitor	2.2 μF		
L1	stripline (note 2)	50 Ω	54 mm × 4.7 mm	
L2	5 turns enamelled 0.4 mm copper wire		int. dia. 3 mm	
L3, L7	grade 3B1 Ferroxcube wideband RF choke			4312 020 36640
L4	stripline (note 2)	50 Ω	36 mm × 4.7 mm	
L5	1 turn enamelled 1.4 mm copper wire	5 nH	int. dia. 4 mm	
L6	3 turns enamelled 0.4 mm copper wire		int. dia. 3 mm	
R1, R2	0.25 W metal film resistor	10 Ω, 5%		

#### **Notes**

- 1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
- 2. The striplines are mounted on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric ( $\epsilon_r$  = 2.2); thickness 1/16 inch.

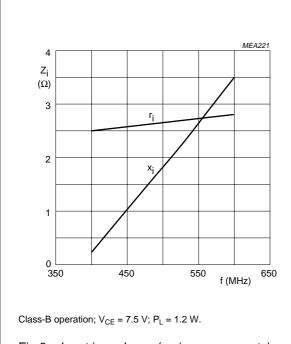
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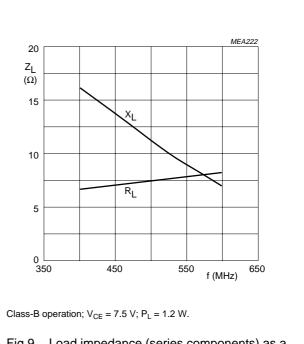
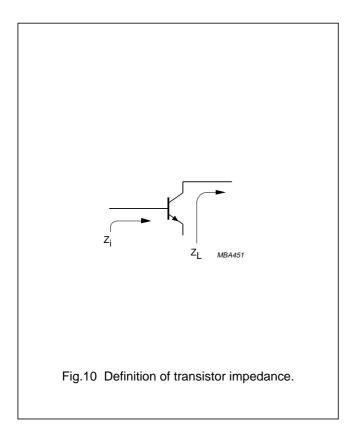
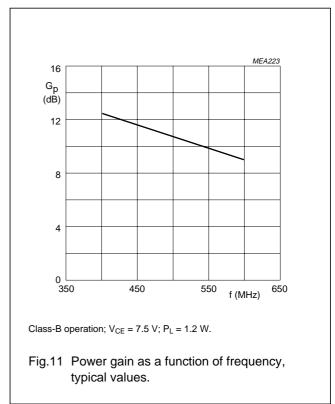


Fig.8 Input impedance (series components) as a function of frequency, typical values.

Fig.9 Load impedance (series components) as a function of frequency, typical values.





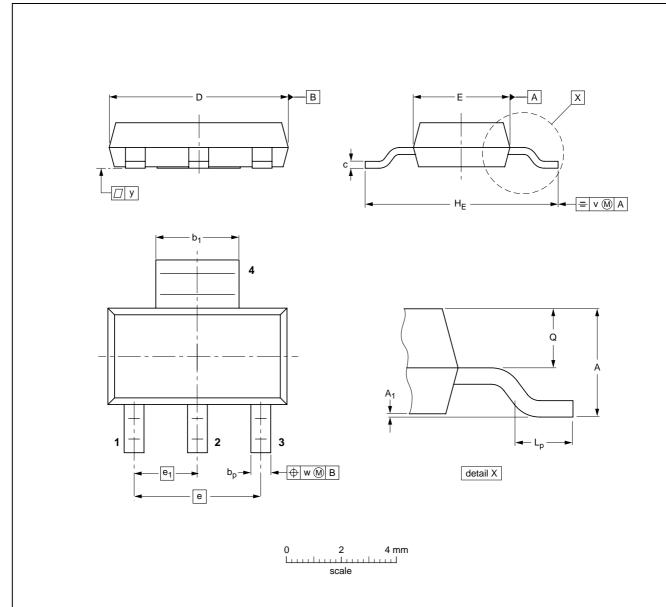
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#### **PACKAGE OUTLINE**

Plastic surface mounted package; collector pad for good heat transfer; 4 leads

**SOT223** 



#### **DIMENSIONS** (mm are the original dimensions)

UNIT	А	A <sub>1</sub>	bp	b <sub>1</sub>	С	D	E	е	e <sub>1</sub>	HE	Lp	Q	٧	w	у
mm	1.8 1.5	0.10 0.01	0.80 0.60	3.1 2.9	0.32 0.22	6.7 6.3	3.7 3.3	4.6	2.3	7.3 6.7	1.1 0.7	0.95 0.85	0.2	0.1	0.1

OUTLINE	DUTLINE REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT223						<del>96-11-11</del> 97-02-28

Product specification Philips Semiconductors

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#### **DEFINITIONS**

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

#### **Application information**

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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